Notice of References Cited Application/Control No. 10/517,324 Examiner DANA SHIN Applicant(s)/Patent Under Reexamination LIANG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-2004/0146858 A1	07-2004	Li et al.	435/005	
	В	US-				
	C	US-				
	D	US-				
	Е	US-				
	F	US-				
	G	US-				
	Ξ	US-		i = + ii		
		US-				
	J	US-				
	К	US-				
	Ĺ	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ζ					
	0					
	Ρ		A			
	σ					
	R					
	s					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.